

MIXED TCR BEHAVIOUR OF GD-DOPED BaTiO₃ CERAMICS WITH SINTERING AIDS

GAMA S.B. AND RAIBAGKAR R.L.*

Department of Post Graduate Studies and Research in Materials Science, Gulbarga University, Gulbarga-585106 (Karnataka) India.

*Corresponding Author: Email- rlraibagkar@rediffmail.com

Abstract- Polycrystalline perovskite ceramics of composition (Ba_{1-x}Gd_x)TiO₃, (0.001≤x≤0.005) with sintering aids were prepared by solid state reaction technique. Temperature coefficient of resistivity (TCR) behaviour was studied in the temperature range 30^oC to 300^oC. It is observed that, inclusion of sintering aids lowered the sintering temperature and the room temperature resistivity (ρ_{RT}) and also enhances the positive TCR (PTCR) at the ferroelectric Curie temperature, T_c. PTCR property begins from room temperature and remains up to T_c, thereafter show NTCR behaviour, with nearly same range of TCR values for all the samples, which shows the improved TCR properties due to sintering aids in the Gd-doped BaTiO₃ ceramics.

1. INTRODUCTION

Pure barium titanate ceramics are normally insulating materials with high resistance at room temperature 10⁹-10¹³Ω cm. With a small amount of donor dopants, such as La³⁺ or other rare-earth ions at Ba²⁺-site or with Nb⁵⁺ at Ti⁴⁺-site, the material becomes semiconductor at room temperature [1]. Barium titanate ceramics when doped with a small proportion of donors can be converted to a semiconducting material [2] and exhibits an anomalous increase in resistivity near the ferroelectric Curie point. This behavior is commonly known as positive temperature coefficient of resistance (PTCR) [3]. The PTCR performance is an effect of grain boundary. The main composition of a grain boundary is sintering aids and acceptors. Acceptors play an important role in the PTCR performance when they are well distributed in a grain boundary [4, 5]. In particular, this is

achieved when rare-earth ions are partially substituted for Ba²⁺ ions and grain boundaries are oxidized during sintering of the ceramic samples in air. Rare earth oxides, e.g. Gd₂O₃ and Dy₂O₃, inhibit grain growth in BaTiO₃ ceramics; moreover addition of such oxides alters the crystal chemistry [6], because of the difference between the ionic radii of the trivalent rare-earth ions and those of Ba²⁺ and Ti⁴⁺ ions [7]. The

BaTiO₃ sintered in air are semi-conductive for Gd-concentration of 0.05 to 0.1 at%. For air sintered BaTiO₃, more than 0.2 to 0.4 at% Gd, grain growth inhibition begins, lattice parameters changes and electrical conductivity begins to decrease [8].

Normally, donor-doped BaTiO₃ ceramics can be prepared by the mixed oxides solid state reaction method. SiO₂ or a eutectic mixture like Al₂O₃-SiO₂-TiO₂ (AST) or Y₂O₃-SiO₂-TiO₂ (YST) is added

as the sintering aids, which results in the formation of liquid phase in between 1240^oC-1260^oC, thereby lowers the sintering temperature [9]. Usually, the microstructure of such ceramics is a result of liquid phase sintering. The required liquid phase is formed by a reaction between a suitable additive and the BaTiO₃ matrix powder. Addition of SiO₂ promotes anomalous grain growth and lowers the sintering temperature of BaTiO₃ ceramics. Chen et al [10] studied the effect of YST sintering aids on PTCR properties of (Pb_{0.6}Sr_{0.3}Ba_{0.1})TiO₃, revealed incorporation of sintering aids. SiO₂ has lowered the sintering temperature necessary from 1250^oC (10 min) to 1140^oC (10 min). The materials were stabilized only when they contained more than 7.5mol% SiO₂ and were sintered at 1120^oC (10 min) and higher temperature. Here, an attempt has been done to study the PTCR of Gd-doped BaTiO₃ with sintering aids prepared at temperature 1120^oC.

EXPERIMENTAL PROCEDURE

The ceramic sample having composition (Ba_{1-x}Gd_x)TiO₃ (BGT) with x=0.001-0.005 by solid-state reaction method. High purity (99.99%) chemicals, BaCO₃, TiO₂, Gd₂O₃, Y₂O₃ and SiO₂ in their stoichiometric proportions SBGT samples were labeled as SBGT₁ for x=0.001, SBGT₂ for x=0.002, SBGT₃ for x=0.004, and SBGT₄ for x=0.005 with sintering aids YST (1mol% Y₂O₃, 7.5 mol% SiO₂ and 3 mol% of excess TiO₂) were weighed, mixed and grounded thoroughly in an agate mortar for 4 hrs. SBGT samples were calcined in air media at 950^oC and at 1000^oC for 8 hrs in an alumina crucibles, with intermediate grindings for 2 hrs, in a programmable high temperature muffle. The finished powder was pressed and plastified using aqueous (5%) polyvinyl alcohol into a circularly shaped disc pellets of 10mm diameter and thickness of 1.5mm using tungsten carbide die

and plunger with hydrostatic pressure of 45 kN/m². The pellets were sintered at 1120^oC and annealed at 1050^oC for 1hr. The heating and cooling rate for all thermal cycles was 2^oC/min. The sintered pellets were polished and coated with silver paint and later cured at 400^oC for 1hr. The DC electrical conductivity was estimated by measuring the resistivity with two-probe employing a digital multimeter (Keithley, Model 2000) in the temperature range 30^oC-300^oC.

RESULTS AND DISCUSSION

The SBGT ceramic samples were prepared by solid state reaction method. Figure 1 shows the resistivity vs. temperature characteristics for SBGT samples (SBGT₁, SBGT₂, SBGT₃ and SBGT₄). The dc resistivity (ρ_{dc}) was evaluated from the measured resistance multiplied by a geometrical factor A/t, where A and t are the area and thickness of the testing sample respectively. It is observed that the resistivity of SBGT₁ samples at room temperature is less than that of SBGT₂, SBGT₃ and SBGT₄ samples and the magnitude of the PTCR jump and PTCR coefficient of SBGT₁ samples decreases for the higher Gd content. The room temperature resistivity (ρ_{RT}), maximum resistivity (ρ_{max}), resistivity jump (ρ_{max}/ρ_{RT}), TCR and E_a values are shown in Table 1.

The temperature resistivity coefficient, α , (TCR) is defined as

$$\alpha = 2.303 \{ \log [R_a/R_b] / [T_a - T_b] \} \times 100 (\% / ^\circ C)$$

where R_a is the resistivity at temperature T_a and R_b is the resistivity at temperature T_b [11]. The obtained α_{PTCR} value is \approx 2-15 %/^oC and α_{NTCR} value is \approx 1.5-12 %/^oC. Like Al₂O₃, the inclusion of Y₂O₃ sintering aid, raises the room-temperature resistivity slightly, which possibly arises from the formation of incompletely compensated surface states [12-14], due to the segregation of Y³⁺ at grain boundary regions. The grain-boundary Schottky barrier is not

completely suppressed below the Curie point [15, 16]. Similarly, the addition of SiO₂ moderately lowers the room-temperature resistivity. The high-temperature resistivity of all the samples is changed. Since the high-temperature resistivity is known to be due to the formation of the Schottky barrier at the grain boundaries, it is thus inferred that the liquid phase resulted from YST sintering aids will accumulate gradually at junctions of grains such that the grain boundaries are almost free from the YST phase. These ions act as electron trap, which increase the Schottky barrier height and in turn, raises the T_c of the samples [17].

All our samples demonstrated mixed TCR effect i.e., PTCR as well as Negative TCR (NTCR) behaviour. Here, Gd³⁺ act as electron donor and charge compensation results in variation of electrical conductivity. It was reported that the doped-BaTiO₃ ceramic sintered in air at 1280°C is semiconductive only at Gd content of 0.05-0.1 at%. For air-sintered specimens of BaTiO₃ containing Gd>0.2-0.4 at%, grain growth inhibition begins, hence lattice parameters changes, and electrical conductivity begins to decrease [18].

The activation energy (E_a) is obtained from the inclinations of log conductivity vs. reciprocal of absolute temperature curve. It is found to be 0.215eV to 0.985eV in the PTC region and 0.107 eV to 0.204 in the NTC region.

CONCLUSION

The synthesized Gd³⁺-doped BaTiO₃ with YST sintering aids exhibited mixed TCR behaviour. PTCR property begins from room temperature and remains up to T_c and further show NTCR behaviour, with nearly same range of TCR values for all the samples, which shows the improved TCR properties due to YST aids. High temperature resistance is due to grain-growth inhibition and electrical charge compensation. Improved TCR coefficient is due to incorporation of YST

aids, which lowered the sintering temperature from the reported 1280°C to 1140°C.

ACKNOWLEDGEMENT

One of the authors (GSB) would like to thank University Grant Commission, New Delhi for award of FIP.

REFERENCES

- [1] Mitoseriu L, Siri A S, Okuyama D R and Nanni P, J. Kor. Phys. Soc., 42, 1088 (2000).
- [2] Tsai-Fa Lin, Chen-Ti Hu and I-Nan Lin, J. Am. Ceram. Soc. 73(3) (1990) 531-536.
- [3] Satendra Pal Singh, Akhilesh Kumar Singh and Dhananjai Pandey, Ferroelectrics, 324(2005) 45-53.
- [4] Osamu Saburi, J. Am. Ceram. Soci., Vol. 44, 54(1961).
- [5] Anatoli Belous, Oleg V' Yunov, Leonid Kovalenko., Mat. Res. Bull., 39, 297 (2004).
- [6] J. Illingsworth, H. M. AL-Allak, A. W. Brink. Man and J. Woods, J. Appl. Phys., 67, 2088 (1990).
- [7] Jun Gyu Kim, Won-Seung Cho and Kyeongsoon Park, Mat. Sci. Engg.B94, 149 (2002).
- [8] Toshiaki Murakami, Tadashi Miyashita, Motohiro Nakahara and Eiji Shekin, J. Am.Ceram. Soc., 56, 294(1973)
- [9] Wang X. X. Chan H. L. W. Pang G. K. and H. Choy, Mat. Sci. Engg. B100, 286 (2003).
- [10] Hu C. T., Chen H.W., Chang H.Y. and Lin I.N., Jpn. J. Appl. Phys., 37, 186 (1998).
- [11] Moratis C. J. Bratton R.J., Jap. J. Appl. Phys., 10, 421 (1971).
- [12] Heywang W., J. Mater. Sci., 6, 1214 (1971).
- [13] Miller C A., J. Phys. D, 4, 690 (1971).
- [14] Al-Allak H. M. Russell G.J. and Woods J., J. Phys., D20, 1645 (1987).

- [15] Ihrig H. and Klerk., Appl. Phys. Letts., 35, 307 (1979).
 [16] Koschek G. and Kubalek E., Ferroelectrics, 68, 293 (1986).
 [17] Cheng H. F., J. Appl. Phys., 66, 1382 (1989).
 [18] Murakami T., Miyashita T., Nakahara M. and Shekin E, J. Am. Ceram. Soci., 56, 294(1973).

Table 1- Electrical data of synthesized samples

Sample code →		SBGT ₁	SBGT ₂	SBGT ₃	SBGT ₄
Electrical Parameters ↓					
$\rho_{RT} \times 10^8 (\Omega \cdot \text{cm})$		2.10x10 ⁵	2.75x10 ⁸	3.14x10 ⁸	2.75x10 ⁸
$\rho_{max} \times 10^{10} (\Omega \cdot \text{cm})$		8.00x10 ⁸	0.18x10 ¹⁰	0.38x10 ¹⁰	0.51x10 ¹⁰
ρ_{max}/ρ_{RT}		3.92x10 ³	0.68x10	1.22x10	1.85x10
T _C (°C)		130	50	80	100
TCR (%/°C)	PTCR	2 to 15.62	3.1 to 7.44	5.75 to 6.37	3.0 to 12.0
	NTCR	-1.4 to -4.9	-2.3 to -36.7	-1 to -12.7	-1.5 to -3.07
Activation energy (eV)	+E _a	0.9845	0.3019	0.1481	0.2156
	-E _a	0.2042	0.1258	0.1306	0.1078

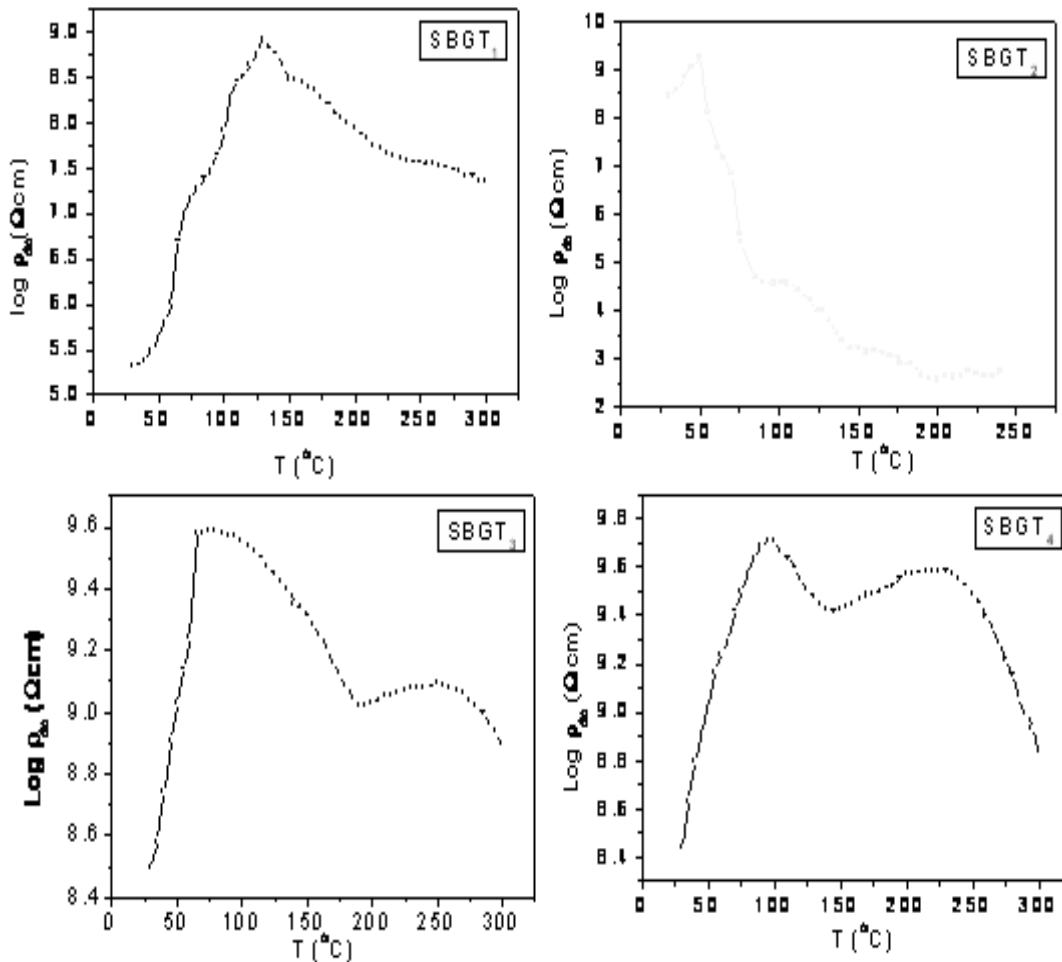


Fig. 1- Resistivity-Temperature characteristics of SBGT samples